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Final Product/Process Change Notification Document #: FPCN20888XD

Issue Date: 2 June 2017

| Title of Change: | Qualification of United Microelectronics Corp (UMC), Taiwan as an additional wafer fabrication facility for Trench 3 Schottky MOSFETs. | | | |
|--|--|--|--|--|
| Proposed first ship date: | 9 September 2017 | | | |
| Contact information: | Contact your local ON Semiconductor Sales Office or <guokun.yeng@onsemi.com></guokun.yeng@onsemi.com> | | | |
| Samples: | Contact your local ON Semiconductor Sales Office | | | |
| Additional Reliability Data: | Contact your local ON Semiconductor Sales Office or < <u>Don.Knudsen@onsemi.com></u> | | | |
| Type of notification: | This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact <pcn.support@onsemi.com>.</pcn.support@onsemi.com> | | | |
| Change Part Identification: | There will be change to the finished good part marking on product assembled with the Trench Die fabricated from the UMC Wafer Fab facility. Full traceability of the die manufacturing facility will be available through the lot number recorded on the shipping labels. | | | |
| Change category: | ■ Wafer Fab Change | | | |
| Change Sub-Category(s): ☐ Manufacturing Site Change/Addition ☐ Manufacturing Process Change ☐ Product specific change ☐ Other: | | | | |
| Sites Affected: All site(s) not ap | plicable ON Semiconductor site(s): External Foundry/Subcon site(s) UNITED MICROELECTRONICS CORP, TAIWAN | | | |
| Description and Purpose: This Product Change Notice is to announce that ON Semiconductor is adding wafer fabrication capacity for their Trench 3 Schottky MOSFET technology silicon platforms. ON Semiconductor has qualified United Microelectronics Corp (UMC), a wafer fabrication facility located in Taiwan. Upon expiration of this FPCN, ON Semiconductor will supply parts utilizing the UMC fab. Device quality and reliability will continue to meet ON | | | | |

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Reliability Data Summary:

QV Device Name: NTMFS4933NT1G; NTMFS4935NT1G; NTMFS4982NFT1G

| Test | Name | Test Conditions | Test Results | (rej/ ss) | (rej/ ss) | (rej/ss) | (rej/ ss) |
|--------------------|---|--|-----------------------|--------------------|--------------------|--------------------|--------------------|
| | | | Read Point | Lot A NTMFS4933 | Lot B NTMFS4933 | Lot A NTMFS4935 | Lot B NTMFS4935 |
| Prep | Sample preparation and initial part testing | various | Initial Electrical | done | done | done | done |
| HTRB | High Temp Reverse Bias | TA = 150°C , Vgss = 100% of max rated | 504 Hrs | 0/77 | 0/77 | 0/77 | 0/77 |
| HTGB | High Temp Gate Bias | TA = 150°C , Vdss = 80% of max rated | 504 Hrs | 0/77 | 0/77 | 0/77 | 0/77 |
| MSL 1 PC - IOL | Intermittent Operating Life + PC | Ta=+25°C, delta Tj=100°C On/of = 2 min | 7500 Hrs | 0/77 | 0/77 | 0/77 | 0/77 |
| MSL 1 PC - TC | Temperature Cycling + PC | -55 °C to + 150°C | 500 Cyc | 0/77 | 0/77 | 0/77 | 0/77 |
| MSL 1 PC - AC | Autoclave + PC | 121°C/100% RH/15psig | 96 Hrs | 0/77 | 0/77 | 0/77 | 0/77 |
| MSL 1 PC - HAST | Highly Accelerated Stress Test | Temp= +131°C, RH=85% , p = 18.8 psig, bias | 96 Hrs | 0/77 | 0/77 | 0/77 | 0/77 |

| Test | Name | Test Conditions | End Point Req's | Test Results | (rej/ ss) | (rej/ ss) | (rej/ss) |
|------|--|------------------------------|--------------------|-----------------------|----------------------|----------------------|----------------------|
| | | | | Read Point | Lot A NTMFS4982NF | Lot B NTMFS4982NF | Lot C NTMFS4982NF |
| Prep | Sample preparation and initial part testing | various | | Initial Electrical | done | done | done |
| HTRB | High Temp Reverse Bias | Tj = 150°C for 1008 hours | c = 0, Room | 168 hr | 0/84 | 0/84 | 0/84 |
| | | | | 504 Hrs | 0/84 | 0/84 | 0/84 |
| | | | | 1008 Hrs | 0/84 | 0/84 | 0/84 |

Electrical Characteristic Summary:

There is no change in electrical parametric performance. Characterization data is available upon request.

List of Affected Standard Parts:

| Part Number | Qualification Vehicle | | |
|----------------|--|--|--|
| NTMFD4952NFT1G | NTMFS4933NT1G NTMFS4935NT1G NTMFS4982NFT1G | | |

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